

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent of:

Amar GUETTAF

Patent. No.: 7,395,468 B2

Issued: July 1, 2008

For: **Methods for Debugging Scan Testing  
Failures of Integrated Circuits**

Confirmation No.: 1879

Atty. Docket: 1875.4450000

**Request for Certificate of Correction  
under 37 C.F.R. § 1.322**

*Attn: Certificate of Correction Branch*

Commissioner for Patents  
PO Box 1450  
Alexandria, VA 22313-1450

Sir:

It is hereby requested that a Certificate of Correction under 37 C.F.R. § 1.322 and 1.323 be issued for the above-captioned United States Patent. This Certificate of Correction is being requested due to a mistakes which appear in the printed patent. This mistakes were made by the U.S. Patent and Trademark Office.

Specifically, the printed patent contains the following errors for which a Certificate of Correction is respectfully requested:

Column 11, line 17, "bad san paths" should be replaced with --  
bad scan paths--.

Column 11, line 19, "Wherein" should be replaced with --  
wherein--.

Column 11, line 38, "the path scan path" should be replaced with  
--the bad scan path--.

Support for the correction can be found in the Amendment filed

December 27, 2007.

**Remarks**

The above-noted corrections do not involve such changes in the patent as would constitute new matter or would require reexamination.

A completed Form PTO/SB/44 accompanies this request, with the above-noted correction printed thereon. Accordingly, a Certificate of Correction is believed proper and issuance thereof is respectfully requested.

The Commissioner is hereby authorized to charge any fee deficiency, or credit any overpayment, to our Deposit Account No. 19-0036.

Respectfully submitted,

STERNE, KESSLER, GOLDSTEIN & FOX P.L.L.C.



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UNITED STATES PATENT AND TRADEMARK OFFICE  
CERTIFICATE OF CORRECTION

PATENT NO. : 7,395,468 B2  
DATED : July 1, 2008  
INVENTOR(S) : Amar GUETTAF

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Column 11, line 17, "bad san paths" should be replaced with --bad scan paths--.

Column 11, line 19, "Wherein" should be replaced with --wherein--.

Column 11, line 38, "the path scan path" should be replaced with --the bad scan path--.

MAILING ADDRESS OF SENDER:

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PATENT NO. 7,395,468 B2

No. of additional copies

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This collection of information is required by 37 CFR 1.322, 1.323, and 1.324. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 1.0 hour to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: **Attention Certificate of Corrections Branch, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.**

If you need assistance in completing the form, call 1-800-PTO-9199 and select option 2.